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## IN THE UNITED STATES DESIGNATED OFFICE (DO/US)

In re: Hamilton, et al.

Attn: DO/US

International Appl. No.: PCT/GB2003/002599

International Filing Date: June 17, 2003

For: DIGITAL SYSTEM AND METHOD FOR TESTING

ANALOGUE AND MIXED SIGNAL CIRCUITS OR SYSTEMS

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Sir:

At least some of the patents and publications listed on the attached PTO-1449 were cited in the above-referenced application and/or the International Search Report of corresponding International Application No. PCT/GB2003/002599. Copies of the Search Report and Examination Report are enclosed for the Examiner's convenience and consideration. In accordance with the Office waiver published July 11, 2003, copies of the cited U.S. patents and patent application publications are not enclosed. Applicant does enclose copies of any cited foreign patent documents and non-patent literature in accordance with 37 CFR 1.98(a)(2).

The Examiner may wish to consider the notations on the Search Report itself regarding the relevance of each item. It is requested that the Examiner consider these references and officially make them of record in accordance with the provisions of 37 C.F.R. § 1.97 and Section 609 of the MPEP. By submitting the listed documents, Applicant in no way makes any admission as to the prior art status of the listed documents, but is instead submitting the listed documents for the sake of full disclosure.

Respectfully submitted,

. Vøoper

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Sheila Hayes

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<sup>\*</sup>Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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				Examiner Name	Unknown			
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